



Solid State Devices, Inc.

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SFX5096/5

**1 AMP, 500 Volts
High Voltage PNP Transistor**

DESIGNER'S DATA SHEET

Part Number / Ordering Information ^{1/}

SFX5096

Screening ^{2/} = No Screening
 TX = TX Level
 TXV = TXV Level
 S = S Level

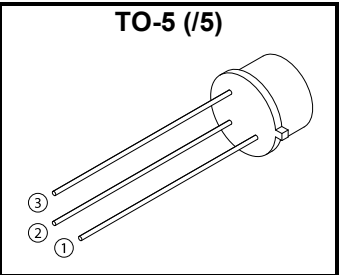
Package ^{3/}
 /5 = TO-5

- Features:**
- V_{CER} to 500 Volts
 - Low Leakage at High Temperature
 - High Linear Gain, Low Saturation Voltage
 - 200°C Operating Temperature
 - Gold Eutectic Die Attach
 - TX, TXV, S-Level Screening Available
 - Designed for Complementary Use with SFT5015
 - Replacement for 2N5094 and 2N5096 with Lower Thermal Resistance

| Maximum Ratings ^{4/} | Symbol | SFX5096 | Units |
|--|-------------------|--|--------------------------|
| Collector – Emitter Voltage ($R_{BE} = 1k\Omega$) | V_{CEO} | 400 | Volts |
| | V_{CER} | 500 | Volts |
| Collector – Base Voltage | V_{CBO} | 500 | Volts |
| Emitter – Base Voltage | V_{EBO} | 6 | Volts |
| Collector Current | I_C | 1.0 | Amps |
| Base Current | I_B | 0.5 | Amps |
| Total Power Dissipation Derate above $T_C = 25^\circ C$ | P_D | 1.0 0.4 5.7 | Watts Watts mW /°C |
| | | ($T_C = 25^\circ C$) ($T_A = 25^\circ C$) | |
| Operating & Storage Temperature | T_J & T_{STG} | -65 to +200 | °C |
| Maximum Thermal Resistance (Junction to Case) | $R_{\theta JC}$ | 30 | °C/W |
| | TO-5 | | |

NOTES:

1/ For ordering information, price, operating curves, and availability, contact factory.
 2/ Screening based on MIL-PRF-19500. Screening flows available on request.
 3/ For Package Outlines, See Figure 1.
 4/ Unless Otherwise Specified, Maximum Ratings/Electrical Characteristics at 25°C.





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SFX5096/5

| Electrical Characteristics ^{4/} | | Symbol | Min | Max | Units |
|--|---|----------------------|-----|-----|-------|
| Collector – Emitter Breakdown Voltage * | (I _C = 5 mA) | BV _{CEO} | 400 | — | Volts |
| | (I _C = 100 μA, R _{BE} = 1k Ω) | BV _{CER} | 500 | — | |
| Collector – Base Breakdown Voltage * | (I _C = 100 μA) | BV _{CB0} | 500 | — | Volts |
| Emitter – Base Breakdown Voltage | (I _E = 50 μA) | BV _{EBO} | 6 | — | Volts |
| Collector Cutoff Current | (V _{CB} = Rated, T _A = 25°C) | I _{CB01} | — | 1.0 | μA |
| | (V _{CB} = Rated, T _A = 100°C) | I _{CB02} | — | 50 | |
| Emitter Cutoff Current | (V _{EB} = 6 V) | I _{EBO} | — | 1.0 | μA |
| DC Current Gain * | (I _C = 1 mA, V _{CE} = 10 V) | H _{FE} | 20 | 250 | |
| | (I _C = 25 mA, V _{CE} = 10 V) | | 40 | 300 | |
| | (I _C = 100 mA, V _{CE} = 10 V) | | 20 | 250 | |
| Collector-Emitter Saturation Voltage * | (I _C = 25 mA, I _B = 2.5 mA) | V _{CE(SAT)} | — | 500 | mV |
| Base-Emitter Saturation Voltage | (I _C = 25 mA, I _B = 2.5 mA) | V _{BE(SAT)} | — | 1.0 | Volts |
| Current Gain Bandwidth Product * | (I _C = 10 mA, V _{CE} = 10 V, f = 10 MHz) | f _T | 40 | — | MHz |
| Output Capacitance | V _{CB} = 20 V, I _E = 0 A, f = 1.0MHz | C _{ob} | — | 60 | pF |
| Turn on Delay Time | V _{CC} = 100 V I _C = 100 mA I _{B1} = I _{B2} = 10 mA | T _d | — | 100 | ns |
| Rise Time | | T _r | — | 350 | ns |
| Storage Time | | T _s | — | 3.2 | μs |
| Fall Time | | t _f | — | 500 | ns |

Notes: * Pulse Test: Pulse Width = 300 μs. Duty Cycle = 2%.
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| PIN ASSIGNMENT (Standard) | | | |
|---------------------------|-----------|---------|-------|
| Package | Collector | Emitter | Base |
| TO-5 (/5) | Pin 3 | Pin 1 | Pin 2 |

